

Notice of References Cited	Application/Control No. 10/591,850		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner DUC M. NGUYEN		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,139,542	11-2006	Vepsalainen et al.	455/266
*	B	US-7,171,185	01-2007	Matsumoto et al.	455/324
*	C	US-7,110,734	09-2006	Mohindra, Rishi	455/234.1
*	D	US-6,442,380	08-2002	Mohindra, Rishi	455/234.1
*	E	US-6,144,243	11-2000	Vaisanen, Risto	327/307
*	F	US-2003/0203727	10-2003	Kluge et al.	455/234.1
*	G	US-2003/0214423	11-2003	Lee et al.	341/118
*	H	US-2002/0197975	12-2002	Chen, Jesse E.	455/324
*	I	US-2003/0156668	08-2003	Atkinson et al.	375/345
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.